

MOSFET MODULE Dual 50A/500V

PDM505HC

FEATURES

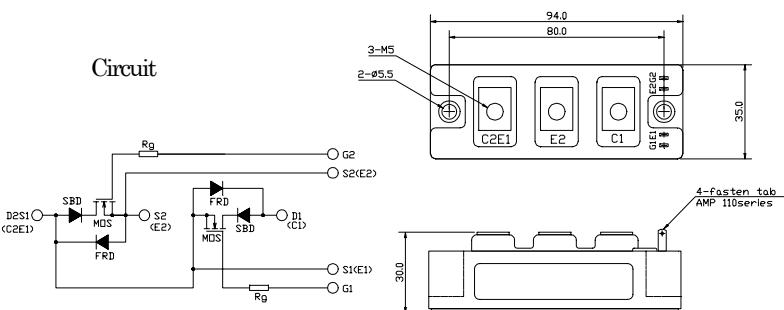
- * Dual MOS FETs Cascaded Circuit
- * Prevented Body Diodes of MOSFETs by SBDs, and Ultra Fast Recovery Diodes Connected in Parallel
- * 300KHz High Speed Switching Possible

TYPICAL APPLICATIONS

- * Power Supply for the Communications and the Induction Heating

OUTLINE DRAWING

Dimension(mm)



Approximate Weight : 220g

MAXMUM RATINGS

| Ratings | | Symbol | PDM505HC | | | Unit |
|---|---------------------------|------------------|---------------------------|--|--|------|
| Drain-Source Voltage (V _{GS} =0V) | | V _{DSS} | 500 | | | V |
| Gate - Source Voltage | | V _{GSS} | +/- 20 | | | V |
| Continuous Drain Current | Duty=50% | I _D | 50 (T _c =25°C) | | | A |
| | D.C. | | 35 (T _c =25°C) | | | |
| Pulsed Drain Current | | I _{DM} | 100 T _c =25°C | | | A |
| Total Power Dissipation | | P _D | 350 T _c =25°C | | | W |
| Operating Junction Temperature Range | | T _{JW} | -40 to +150 | | | °C |
| Storage Temperature Range | | T _{stg} | -40 to +125 | | | °C |
| Isolation Voltage Terminals to Base AC, 1 min.) | | V _{ISO} | 2000 | | | V |
| Mounting Torque | Module Base to Heatsink | F _{TOR} | 3.0 | | | N·m |
| | Bus Bar to Main Terminals | | 2.0 | | | |

ELECTRICAL CHARACTERISTICS (@T_c=25°C unless otherwise noted)

| Characteristic | Symbol | Test Condition | Min. | Typ. | Max. | Unit |
|-----------------------------------|---------------------|---|------|------|------|-------|
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} =V _{DSS} , V _{GS} =0V | - | - | 1.0 | mA |
| | | T _j =125°C, V _{DS} =V _{DSS} , V _{GS} =0V | - | - | 4.0 | |
| Gate-Source Threshold Voltage | V _{Gsth} | V _{DS} =V _{GS} , I _D =3mA | 2.0 | 3.1 | 4.0 | V |
| Gate-Source Leakage Current | I _{GSS} | V _{GS} =+/- 20V, V _{DS} =0V | - | - | 0.3 | μA |
| Static Drain-Source On-Resistance | r _{DSON} | V _{GS} =10V, I _D =25A | - | 110 | 120 | m·ohm |
| Drain-Source On-Voltage | V _{DSON} | V _{GS} =10V, I _D =25A | - | 3.2 | 3.4 | V |
| Forward Transconductance | g _s | V _{DS} =15V, I _D =25A | - | 30 | - | S |
| Input Capacitance | C _{ies} | V _{DS} =25V, V _{GS} =0V, f=1MHz | - | 8.4 | - | nF |
| Output Capacitance | C _{oss} | | - | 1.1 | - | nF |
| Reverse Transfer Capacitance | C _{rss} | | - | 0.24 | - | nF |
| Turn-On Delay Time | t _{d(on)} | V _{DD} = 1/2V _{DSS} I _D =25A V _{GS} = -5V, +10V R _G = 5 ohm | - | 92 | - | ns |
| Rise Time | t _r | | - | 110 | - | |
| Turn-Off Delay Time | t _{d(off)} | | - | 250 | - | |
| Fall Time | t _f | | - | 68 | - | |

FREE WHEELING DIODES RATINGS & CHARACTERISTICS (T_c=25°C)

| Characteristic | Symbol | Test Condition | Min. | Typ. | Max. | Unit |
|---------------------------|-----------------|-------------------------------------|------|------|------|------|
| Continuous Source Current | I _S | D.C. | - | - | 35 | A |
| Pulsed Source Current | I _{SM} | - | - | - | 100 | A |
| Diode Forward Voltage | V _{SD} | I _S =50A | - | - | 1.5 | V |
| Reverse Recovery Time | t _{rr} | I _S =50A, -dI/dt=100A/μs | - | 80 | - | ns |
| Reverse Recovery | Q _r | | - | 0.18 | - | μC |

THERMAL CHARACTERISTICS

| Characteristic | Symbol | Test Condition | Min. | Typ. | Max. | Unit |
|--------------------------------------|---------------------|--|------|------|------|------|
| Thermal Resistance, Junction to Case | R _{th(jc)} | MOS FET | - | - | 0.36 | °C/W |
| | | Diode | - | - | 2.0 | |
| Thermal Resistance, Case to Heatsink | R _{th(ch)} | Mounting surface flat, smooth, and greased | - | - | 0.1 | |

PDM505HC

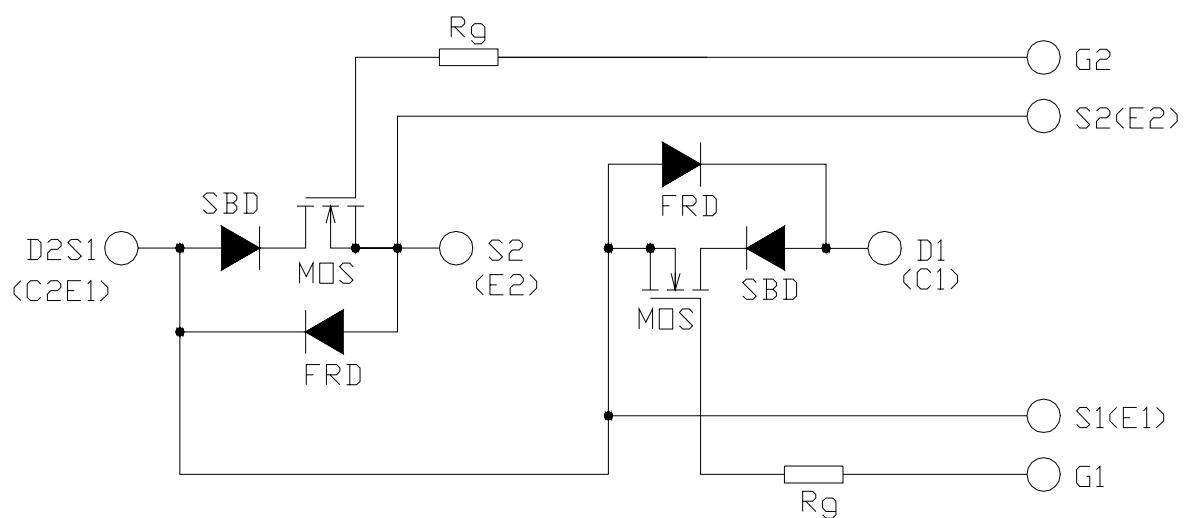
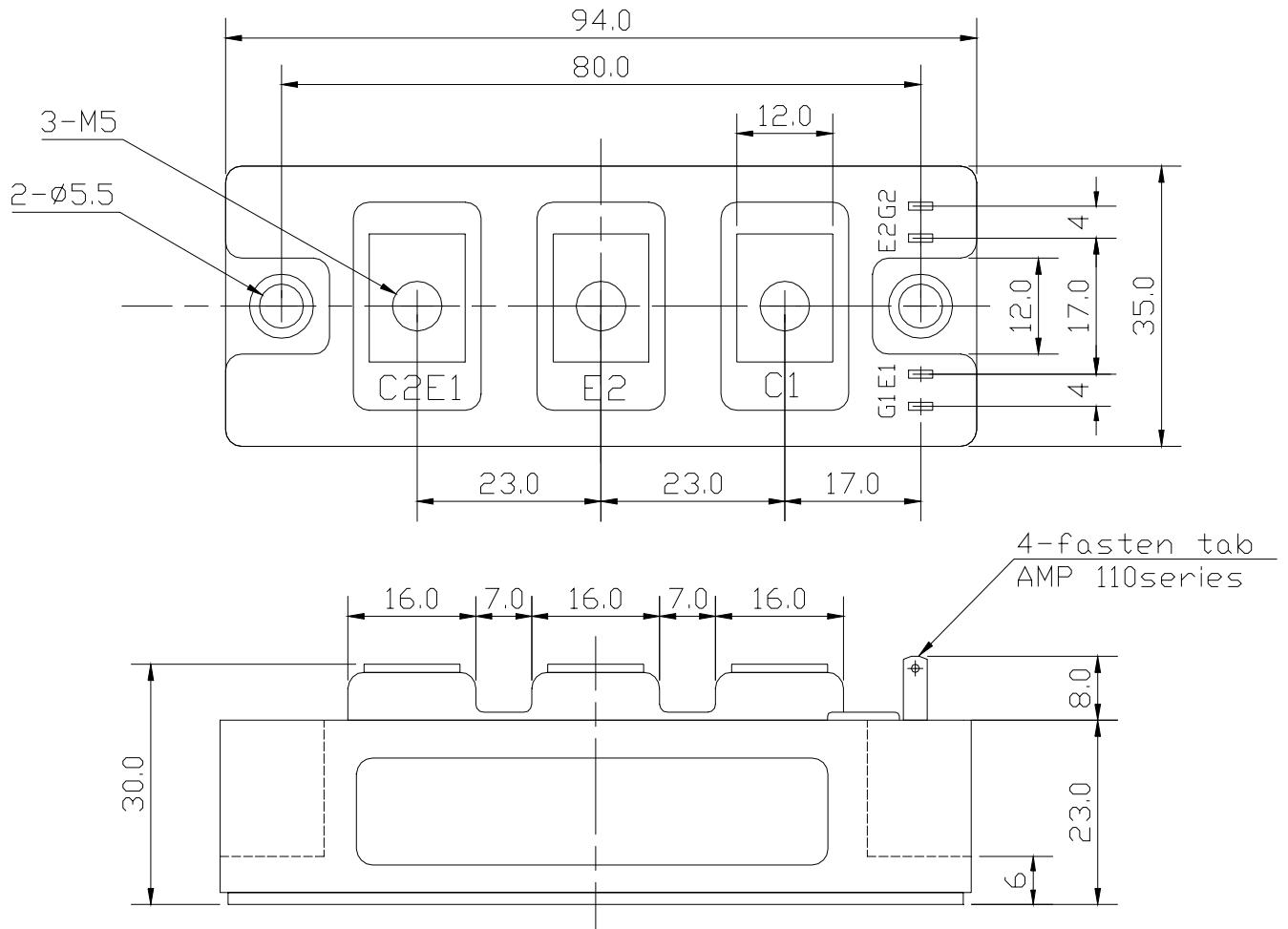


Fig. 1 Typical Output Characteristics

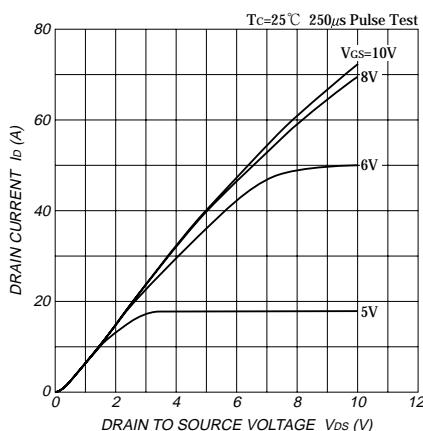


Fig. 4 Typical Capacitance Vs. Drain-Source Voltage

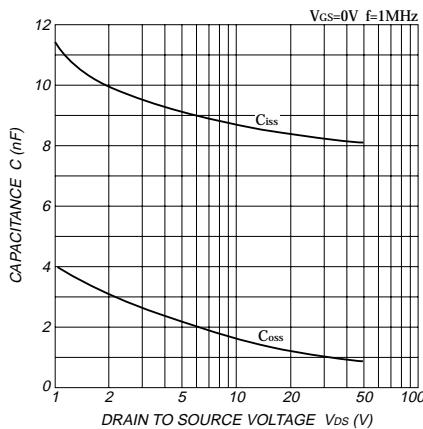


Fig. 7 Typical Switching Time Vs. Drain Current

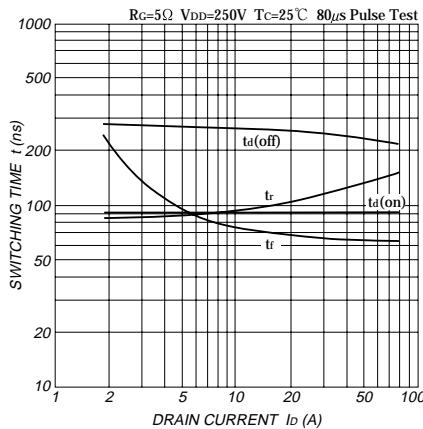


Fig. 10 Maximum Safe Operating Area

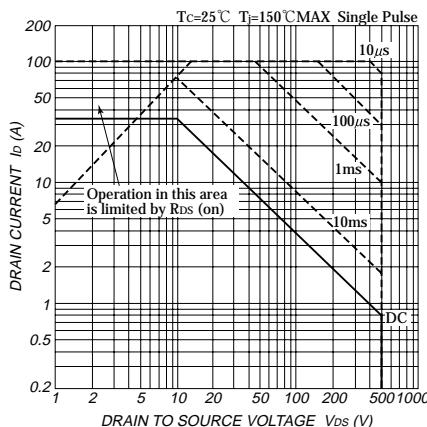


Fig. 2 Typical Drain-Source On-Voltage Vs. Gate-Source Voltage

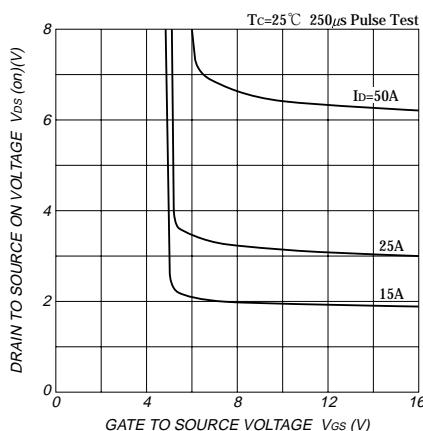


Fig. 3 Typical Drain-Source On Voltage Vs. Junction Temperature

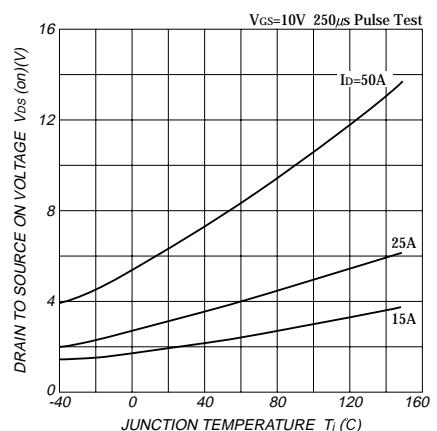


Fig. 5 Typical Gate Charge Vs. Gate-Source Voltage

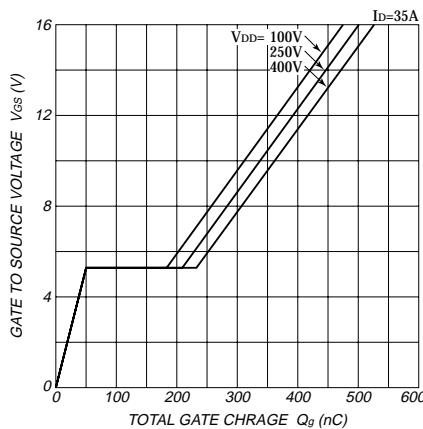


Fig. 6 Typical Switching Time Vs. Series Gate Impedance

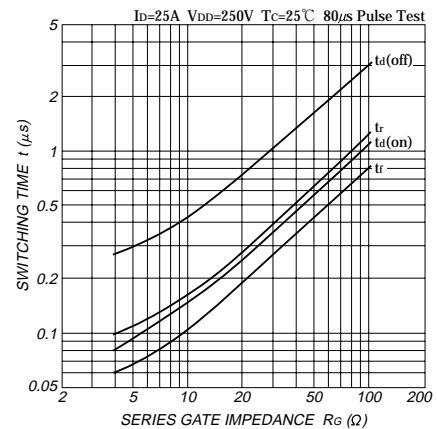


Fig. 8 Typical Source-Drain Diode Forward Characteristics

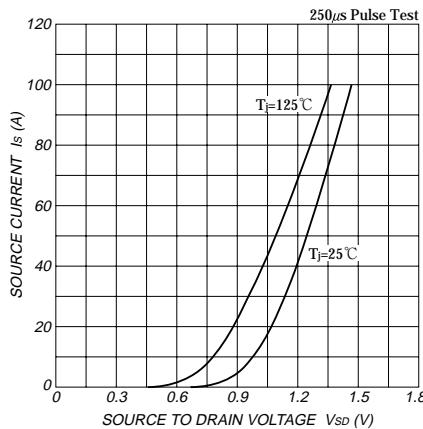


Fig. 9 Typical Reverse Recovery Characteristics

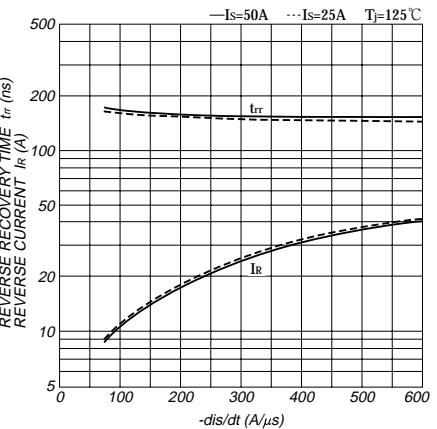


Fig. 11-1 Normalized Transient Thermal Impedance (MOSFET)

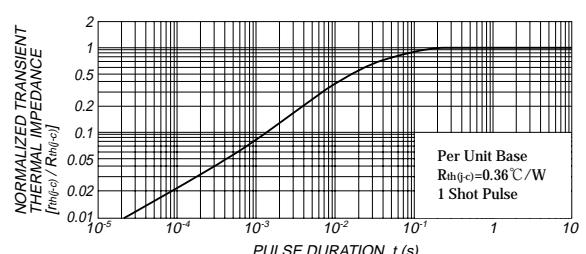


Fig. 11-2 Normalized Transient Thermal Impedance (DIODE)

